

STL80N4LLF3

N-channel 40V - 0.0042Ω - 80A - PowerFLAT™ (6x5) STripFET™ Power MOSFET for DC-DC conversion

General features

Туре	V _{DSS}	R _{DS(on)}	I _D
STL80N4LLF3	40V	<0.005Ω	20A ⁽¹⁾

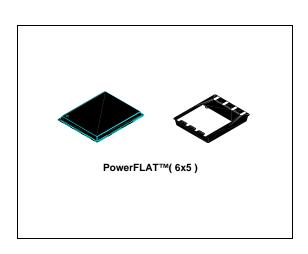
- When mounted on FR-4 board of 1 inch², 2oz Cu, t<10 sec
- Improved die-to-footprint ratio
- Very low profile package (1mm Max)
- Very low thermal resistance
- Conduction losses reduced
- Switching losses reduced



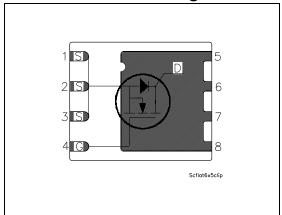
This series of product utilizes the latest advanced design rules of ST's proprietary STripFET™ Technology. The resulting Transistor is optimized for low on-Resistance and minimal gate charge. The chip-scaled PowerFLAT™ package allows a significant board space saving, still boosting the performance.

Applications

■ Switching application



Internal schematic diagram



Order codes

Part number	Part number Marking		Packaging
STL80N4LLF3	STL80N4LLF3 L80N4LLF3		Tape & reel

November 2006 Rev 7 1/12

Contents STL80N4LLF3

Contents

1	Electrical ratings
2	Electrical characteristics
	2.1 Electrical characteristics (curves)
3	Test circuit
4	Package mechanical data
5	Revision history

STL80N4LLF3 Electrical ratings

1 Electrical ratings

Table 1. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V _{DS}	Drain-source voltage (V _{GS} = 0)	40	V
V _{GS}	Gate- source voltage	±16	V
V _{GS} ⁽¹⁾	Gate- source voltage	±18	V
I _D ⁽²⁾	Drain current (continuous) at T _C = 25°C	80	Α
I _D ⁽²⁾	Drain current (continuous) at T _C = 100°C	50	Α
I _D ⁽³⁾	Drain current (continuous) at T _C = 25°C	20	Α
I _{DM} ⁽⁴⁾	Drain current (pulsed)	80	Α
P _{TOT} (2)	Total dissipation at T _C = 25°C	80	W
P _{TOT} ⁽³⁾	Total dissipation at T _C = 25°C	4	W
	Derating factor (3)	0.03	W/°C
T _{stg} T _j	Storage temperature Operating junction temperature	-55 to 150	°C

- 1. Guaranteed for test time \leq 15ms
- 2. The value is rated according Rthj-c
- 3. When mounted on FR-4 board of 1 inch 2 , 2oz Cu, t < 10 sec
- 4. Pulse width limited by safe operating area

Table 2. Thermal resistance

Symbol	Parameter	Value	Unit
Rthj-c	Thermal resistance junction-case max	1.56	°C/W
Rthj-pcb (1)	Thermal operating junction-pcb max	31.2	°C/W

1. When mounted on FR-4 board of 1 inch², 2oz Cu, t<10 sec

Electrical characteristics STL80N4LLF3

2 Electrical characteristics

 $(T_{CASE} = 25^{\circ}C \text{ unless otherwise specified})$

Table 3. On/off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$I_D = 250 \mu A, V_{GS} = 0$	40			٧
I _{DSS}	Zero gate voltage drain current (V _{GS} = 0)	V_{DS} = Max rating V_{DS} = Max rating@125 °C			10 100	μ Α μ Α
I _{GSS}	Gate-body leakage current (V _{DS} = 0)	V _{GS} = ± 16V			±200	nA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1			V
R _{DS(on)}	Static drain-source on resistance	$V_{GS} = 10V, I_D = 10 A$ $V_{GS} = 4.5V, I_D = 10 A$		0.0042 0.005	0.005 0.007	Ω

Table 4. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{iss} C _{oss} C _{rss}	Input capacitance Output capacitance Reverse transfer capacitance	$V_{DS} = 25V, f = 1 \text{ MHz}, $ $V_{GS} = 0$		2530 574 29		pF pF pF
R _G	Gate input resistance	f=1 MHz Gate DC Bias = 0 Test signal level = 20mV open drain	1	3	5	Ω
Q _g Q _{gs} Q _{gd}	Total gate charge Gate-source charge Gate-drain charge	$V_{DD} = 32$ V, $I_D = 20$ A, $V_{GS} = 4.5$ V (see Figure 13)		21.5 6.9 8.2	28	nC nC nC

Table 5. Switching times

Symbol	Parameter	Test conditions	Min	Тур	Max	Unit
$\begin{array}{c} t_{d(on)} \\ t_{r} \\ t_{d(off)} \\ t_{r} \end{array}$	Turn-on delay time Rise time Turn-off delay time Fall time	V_{DD} = 20V, I_D = 10A, R_G = 4.7 Ω V_{GS} = 10V (see Figure 15)		17 25 62 9		ns ns ns

Table 6. Source drain diode

Symbol	Parameter	Test conditions	Min	Тур.	Max	Unit
I _{SD}	Source-drain current				20	Α
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)				80	Α
V _{SD} ⁽²⁾	Forward on voltage	$I_{SD} = 20 \text{ A}, V_{GS} = 0$			1.2	>
t _{rr}	Reverse recovery time	$I_{SD} = 20A, V_{DD} = 20V$		43		ns
Q_{rr}	Reverse recovery charge	di/dt = 100A/μs		64		nC
I _{RRM}	Reverse recovery current	$T_j = 150^{\circ}C$ (see Figure 14)		3		Α

^{1.} Pulse width limited by safe operating area

^{2.} Pulsed: Pulse duration = 300μ s, duty cycle 1.5%

Electrical characteristics STL80N4LLF3

2.1 Electrical characteristics (curves)

Figure 1. Safe operating area

Figure 2. Thermal impedance

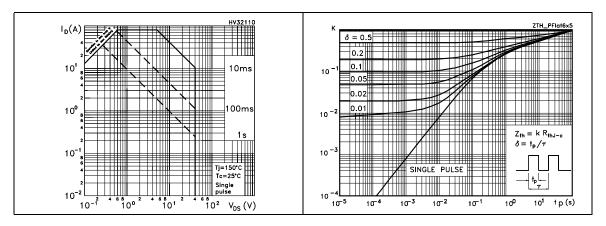


Figure 3. Output characterisics

Figure 4. Transfer characteristics

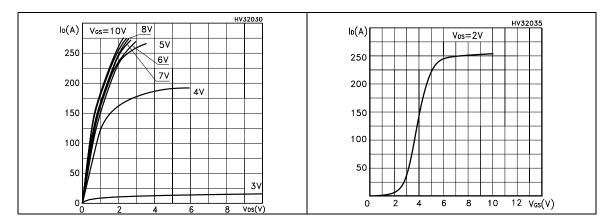


Figure 5. Normalized B_{VDSS} vs temperature

Figure 6. Static drain-source on resistance

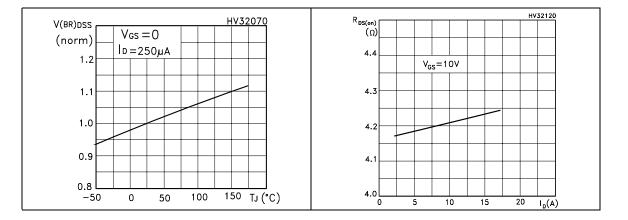


Figure 7. Gate charge vs gate-source voltage Figure 8. Capacitance variations

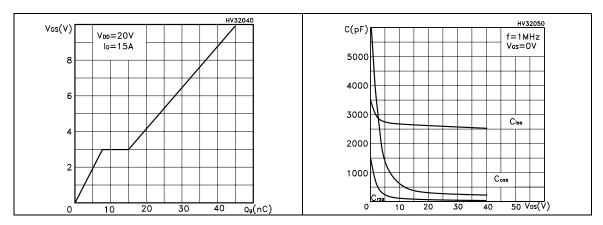


Figure 9. Normalized gate threshold voltage vs temperature

Figure 10. Normalized on resistance vs temperature

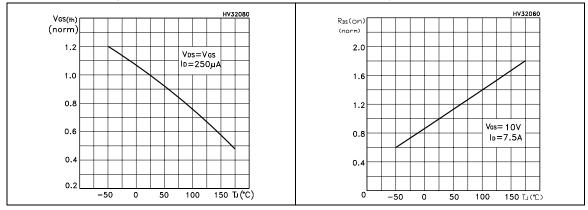
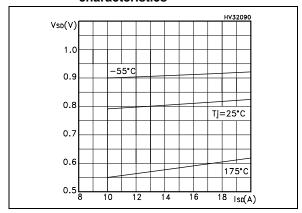


Figure 11. Source-drain diode forward characteristics



4

Test circuit STL80N4LLF3

3 Test circuit

Figure 12. Switching times test circuit for resistive load

Figure 13. Gate charge test circuit

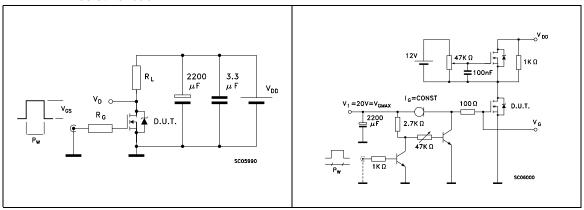


Figure 14. Test circuit for inductive load switching and diode recovery times

Figure 15. Unclamped inductive load test circuit

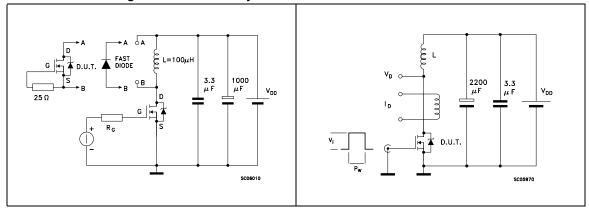
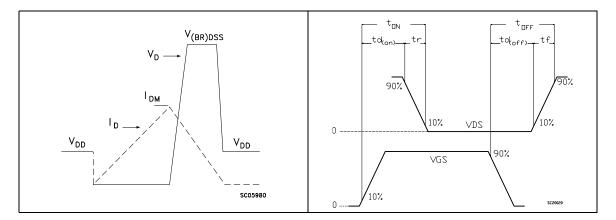


Figure 16. Unclamped inductive waveform

Figure 17. Switching time waveform



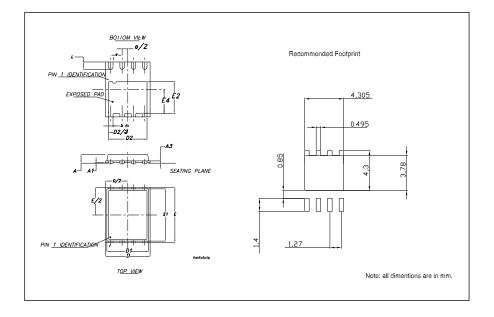
4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com

577

PowerFLAT™	(6x5)	MECHANICAL DATA
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DIM		mm.			inch	
DIM.	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
Α	0.80	0.83	0.93	0.031	0.032	0.036
A1		0.02	0.05		0.0007	0.0019
A3		0.20			0.007	
b	0.35	0.40	0.47	0.013	0.015	0.018
D		5.00			0.196	
D1		4.75			0.187	
D2	4.15	4.20	4.25	0.163	0.165	0.167
E		6.00			0.236	
E1		5.75			0.226	
E2	3.43	3.48	3.53	0.135	0.137	0.139
E4	2.58	2.63	2.68		0.103	0.105
е		1.27			0.050	
L	0.70	0.80	0.90	0.027	0.031	0.035



577

STL80N4LLF3 Revision history

5 Revision history

Table 7. Revision history

Date	Revision	Changes
13-May-2005	1	First release.
20-Jun-2005	2	Updated mechanical data
22-Jun-2005	3	New R _G value on <i>Table 6</i>
04-Jan-2006	4	New footprint
06-Jun-2006	5	Complete version
04-Sep-2006	6	New template, no content change
22-Nov-2006	7	Corrected part number

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477